

Notice of References Cited

Application/Control No.

10/771,474

Applicant(s)/Patent Under
Reexamination
PARK ET AL.

Examiner

Bobbak Safaipoor

Art Unit

2618

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,559,790 A	09-1996	Yano et al.	370/342
*	B	US-5,812,938 A	09-1998	Gilhousen et al.	455/69
*	C	US-6,148,208 A	11-2000	Love, Robert T.	455/442
*	D	US-6,151,328 A	11-2000	Kwon et al.	370/441
*	E	US-6,181,738 B1	01-2001	Chheda et al.	375/224
*	F	US-2001/0053128 A1	12-2001	Lee, Young Jo	370/244
*	G	US-2002/0167913 A1	11-2002	Leung, Gilbert	370/252
*	H	US-6,545,986 B1	04-2003	Stellakis, Haris M.	370/318
*	I	US-6,590,873 B1	07-2003	Li et al.	370/318
*	J	US-6,810,264 B1	10-2004	Park et al.	455/522
*	K	US-2004/0229641 A1	11-2004	Takagi, Kenki	455/522
*	L	US-6,937,640 B2	08-2005	Yun et al.	375/141
*	M	US-6,249,894	06-2001	Lin et al.	714/748

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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